Small Signal MOSFET

30 V, 270 mA, Single N-Channel, SC-70

Features

- Low Gate Charge for Fast Switching
- Small Footprint 30% Smaller than TSOP–6
- ESD Protected Gate
- AEC-Q101 Qualified and PPAP Capable NVS4001N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Low Side Load Switch
- Li-Ion Battery Supplied Devices Cell Phones, PDAs, DSC
- Buck Converters
- Level Shifts

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Paramo	Parameter				Units	
Drain-to-Source Voltage)		V _{DSS}	30	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain	Steady	T _A = 25 °C	I _D	270	mA	
Current (Note 1)	State	T _A = 85 °C		200	1	
Power Dissipation (Note 1)	Steady State	T _A = 25 °C	P _D	330	mW	
Pulsed Drain Current		t =10 μs	I _{DM}	800	mA	
Operating Junction and S	Storage Te	emperature	T _J , T _{STG}	–55 to 150	°C	
Source Current (Body Di	ode)		I _S	270	mA	
	ead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

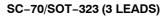
- 1. Surface mounted on FR4 board using 1 in sq. pad size
 - (Cu area = 1.127 in sq. [1 oz] including traces).

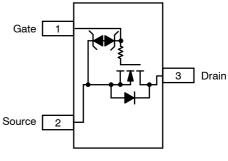


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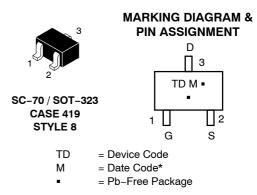
http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D Max
30 V	1.0 Ω @ 4.0 V	270 mA
	1.5 Ω @ 2.5 V	270 111





(Top View)



 (Note: Microdot may be in either location)
*Date Code orientation may vary depending upon manufacturing location.

ORDERING INFORMATION

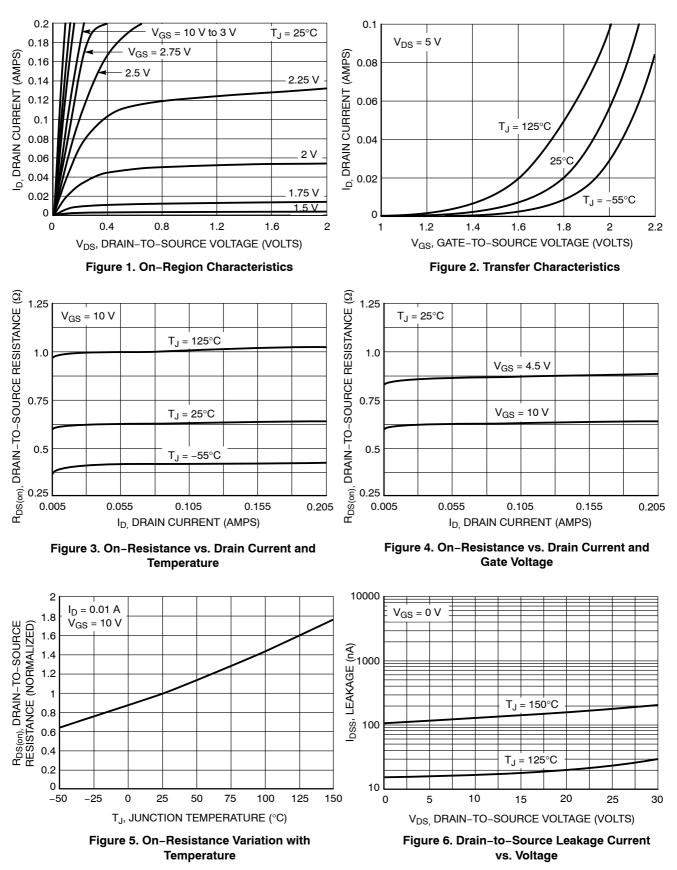
Device	Package	Shipping [†]
NTS4001NT1G	SC-70 (Pb-Free)	3000 / Tape & Reel
NVS4001NT1G	SC-70 (Pb-Free)	3000 / Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS						•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D	= 100 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				60		mV/ °C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _I	_{DS} = 30 V			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _G	_S = ±10 V			±1.0	μΑ
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 100 μA	0.8	1.2	1.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-3.4		mV/ °C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.0 V, I _I	_D = 10 mA		1.0	1.5	Ω
		V _{GS} = 2.5 V, I _D = 10 mA			1.5	2.0	1
Forward Transconductance	9 _{FS}	V _{DS} = 3.0 V, I _D = 10 mA			80		mS
CHARGES AND CAPACITANCES						•	•
Input Capacitance	C _{ISS}				20	33	pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 5.0 V			19	32	-
Reverse Transfer Capacitance	C _{RSS}				7.25	12	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 5.0 V, V _{DS} = 24 V,			0.9	1.3	nC
Threshold Gate Charge	Q _{G(TH)}				0.2		_
Gate-to-Source Charge	Q _{GS}	I _D = 0.1	Í Á		0.3		_
Gate-to-Drain Charge	Q _{GD}		-		0.2		_
SWITCHING CHARACTERISTICS (No	te 3)					•	•
Turn-On Delay Time	td _(ON)				17		ns
Rise Time	tr	V _{GS} = 4.5 V, V _I	- = 5.0 V.		23		_
Turn-Off Delay Time	td _(OFF)	$I_{\rm D} = 10$ mA, $R_{\rm G} = 50 \Omega$			94		_
Fall Time	tf				82		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				•	•	
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.65	0.7	V
		l _S = 10 mA	T _J = 125°C		0.43		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 8.0 A/μs, I _S = 10 mA			5.0		ns

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.



TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

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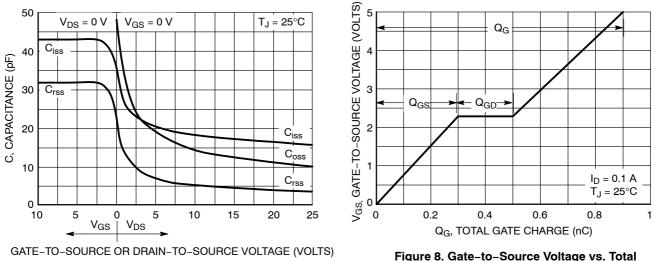


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total Gate Charge

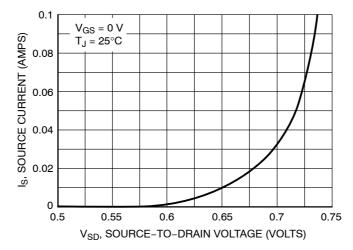
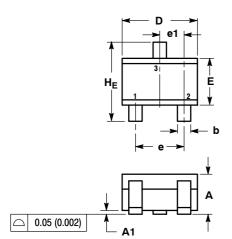


Figure 9. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

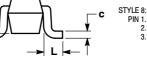
SC-70 (SOT-323) CASE 419-04

ISSUE N



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

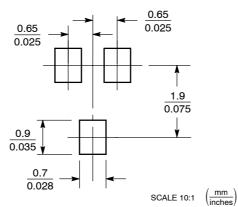
	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.80	0.90	1.00	0.032	0.035	0.040	
A1	0.00	0.05	0.10	0.000	0.002	0.004	
A2	0.70 REF			0.028 REF			
b	0.30	0.35	0.40	0.012	0.014	0.016	
С	0.10	0.18	0.25	0.004	0.007	0.010	
D	1.80	2.10	2.20	0.071	0.083	0.087	
Е	1.15	1.24	1.35	0.045	0.049	0.053	
e	1.20	1.30	1.40	0.047	0.051	0.055	
e1	0.65 BSC			0.026 BSC			
L	0.20	0.38	0.56	0.008	0.015	0.022	
HE	2.00	2.10	2.40	0.079	0.083	0.095	



PIN 1. GATE 2. SOURCE 3. DRAIN

SOLDERING FOOTPRINT*

Δ2



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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